

<b>INFORMATION DISCLOSURE STATEMENT PTO-1449</b>	Attv. Docket No. 032179	Serial No. <sup>10/763,277</sup> <del>New Appln.</del>
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### U.S. PATENT DOCUMENTS

Examiner Initial	Document No.	Name	Date	Class	Subclass	Filing Date (If appropriate)
AA						
AB						

### FOREIGN PATENT DOCUMENTS

	Document No.	Date	Country	Translation (Yes or No)
<i>BuH</i>	AC 4-320219	11/11/92	Japan	Abstract & Discussed in the Spec.
<i>BuH</i>	AD 5-249508	09/28/93	Japan	Abstract & Discussed in the Spec.
<i>BuH</i>	AE 6-59294	03/04/94	Japan	Abstract & Discussed in the Spec.
<i>BuH</i>	AF 6-62450	03/04/94	Japan	Abstract & Discussed in the Spec.
<i>BuH</i>	AG 6-130236	05/13/94	Japan	Abstract & Discussed in the Spec.
<i>BuH</i>	AH 6-289339	10/18/94	Japan	Abstract & Discussed in the Spec.
<i>BuH</i>	AI 8-82810	03/26/96	Japan	Abstract & Discussed in the Spec.

### OTHER DOCUMENTS

<i>BuH</i>	AJ	"2x2 Optical Waveguide Switch with Bow-Tie Electrode Based on Carrier-Injection Total Internal Reflection in SiGe Alloy," Baojun Li and Soo-Jin Chua, pages 206-208, IEEE PHOTONICS TECHNOLOGY LETTERS, VOL. 13, NO.3, MARCH 2001
<i>BuH</i>	AK	Baojun Li, Guozheng Li, Enke Liu, Zuimin Jiang, Chengwen Pei and Xun Wang, Appl. Phys. Lett., pp. 1-3, 75 (1999)
<i>BuH</i>	AL	K. Ishida, H. Nakamura, H. Matsumura, T. Kadi, and H. Inoue, Appl. Phys. Lett., pp.141-142, 50(3), 19 (1987)
Examiner		Date Considered